

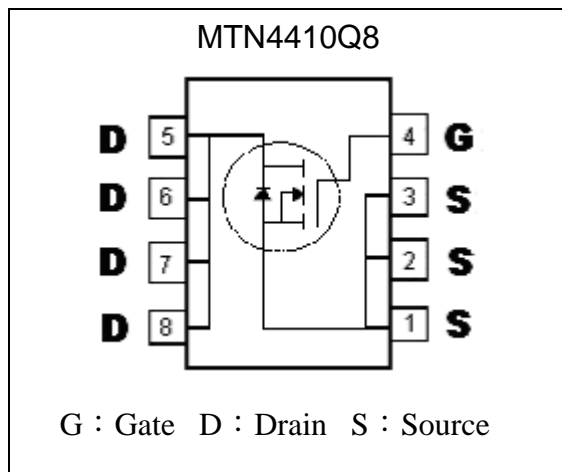
N-Channel Enhancement Mode Power MOSFET

MTN4410Q8

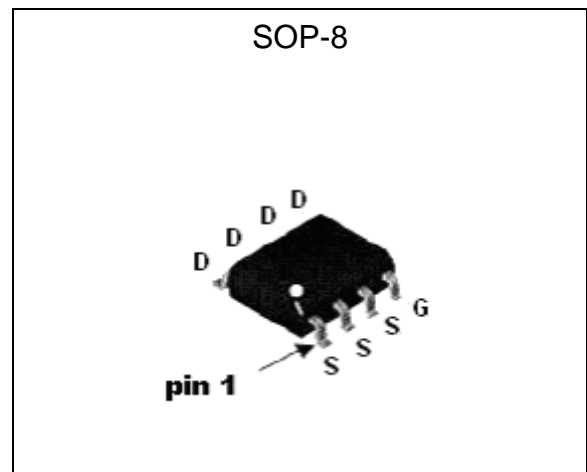
Features

- Single Drive Requirement
- Low On-resistance
- Fast Switching Characteristic
- Pb-free lead plating and halogen-free package

Symbol

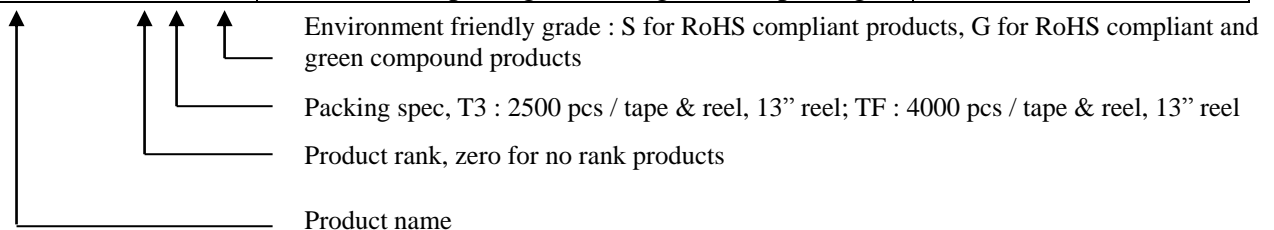


Outline



Ordering Information

Device	Package	Shipping
MTN4410Q8-0-T3-G	SOP-8 (Pb-free lead plating and halogen-free package)	2500 pcs / Tape & Reel
MTN4410Q8-0-TF-G	SOP-8 (Pb-free lead plating and halogen-free package)	4000 pcs / Tape & Reel





Absolute Maximum Ratings (Ta=25°C)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	V _{DS}	30	V
Gate-Source Voltage	V _{GS}	±20	
Continuous Drain Current @ V _{GS} =10V, T _A =25°C	I _D	12	A
Continuous Drain Current @ V _{GS} =10V, T _A =70°C		9.6	
Pulsed Drain Current	I _{DM}	50 *1	
Single Pulse Avalanche Current @ L=0.1mH	I _{AS}	24	
Single Pulse Avalanche Energy @ L=0.1mH, I _{AS} =24A, V _{DD} =15V	E _{AS}	28.8	mJ
Repetitive Avalanche Energy	E _{AR}	3	
Total Power Dissipation	P _D	2.5	W
Linear Derating Factor		0.02	W/°C
Thermal Resistance, Junction-to-ambient, max	R _{th,j-a}	50	°C/W
Operating Junction and Storage Temperature	T _j , T _{stg}	-55~+150	°C

Note : *1. Pulse width limited by safe operating area

Characteristics (T_j=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	30	-	-	V	V _{GS} =0V, I _D =250μA
ΔBV _{DSS} /ΔT _j	-	0.02	-	V/°C	Reference to 25°C, I _D =1mA
V _{GS(th)}	1.0	1.6	3.0	V	V _{DS} = V _{GS} , I _D =250μA
G _{FS}	-	7.6	-	S	V _{DS} =10V, I _D =10A
I _{GSS}	-	-	±100	nA	V _{GS} =±20V, V _{DS} =0V
I _{DSS}	-	-	1	μA	V _{DS} =30V, V _{GS} =0V
	-	-	25		V _{DS} =24V, V _{GS} =0V, T _j =55°C
*R _{DS(ON)}	-	9	13.5	mΩ	V _{GS} =10V, I _D =10A
	-	14	20		V _{GS} =4.5V, I _D =5A
Dynamic					
*Q _g	-	16	-	nC	I _D =10A, V _{DS} =15V, V _{GS} =5V
*Q _{gs}	-	3.8	-		
*Q _{gd}	-	6.2	-		
*t _{d(ON)}	-	7.5	-	ns	V _{DS} =25V, I _D =1A, V _{GS} =5V, R _G =3.3Ω, R _D =25Ω
*t _r	-	17	-		
*t _{d(OFF)}	-	36	-		
*t _f	-	15	-		
C _{iss}	-	1119	-	pF	V _{GS} =0V, V _{DS} =15V, f=1MHz
C _{oss}	-	124	-		
C _{rss}	-	105	-		

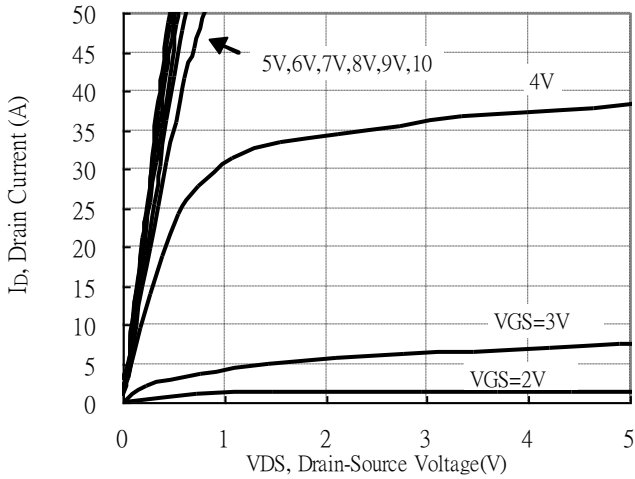


Source-Drain Diode					
*V _{SD}	-	-	1.3	V	I _S =2.3A, V _{GS} =0V
*I _S	-	-	2.3	A	V _D =V _G =0V, V _S =1.3V
*I _{SM}	-	-	9.2		

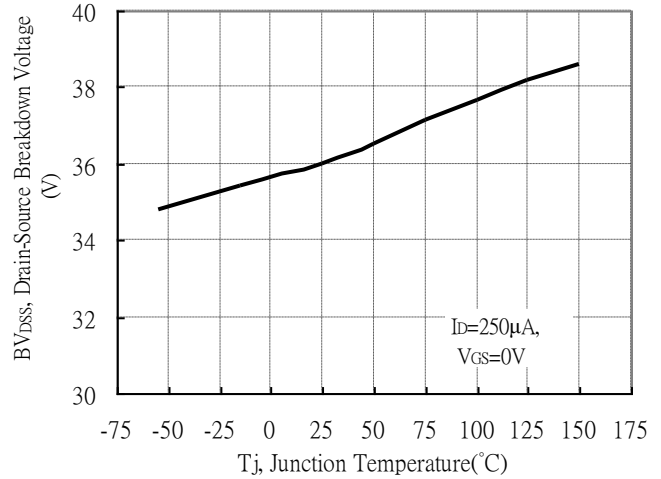
*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

Typical Characteristics

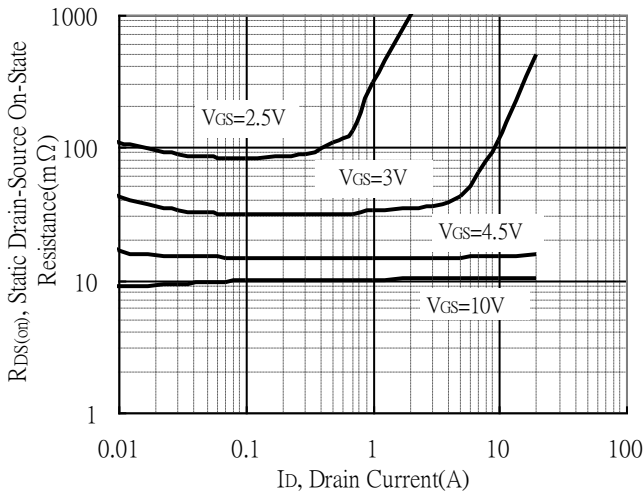
Typical Output Characteristics



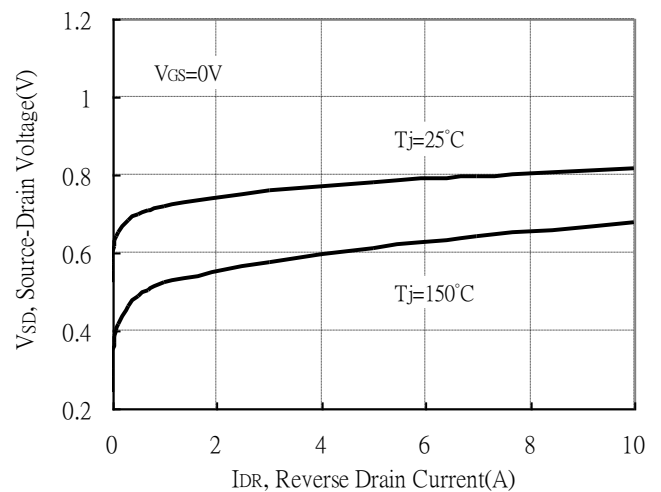
Breakdown Voltage vs Ambient Temperature



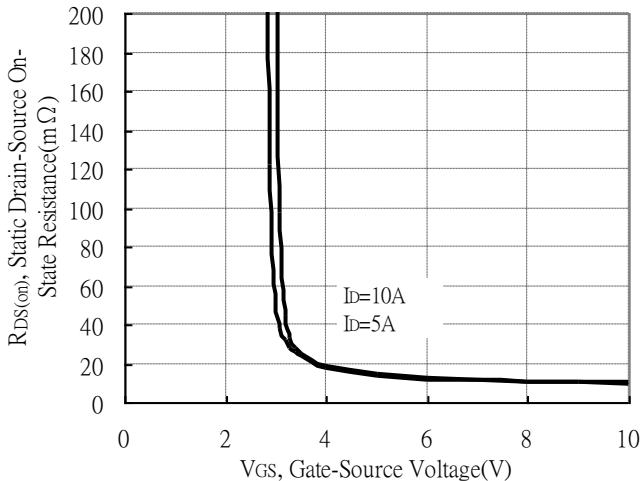
Static Drain-Source On-State resistance vs Drain Current



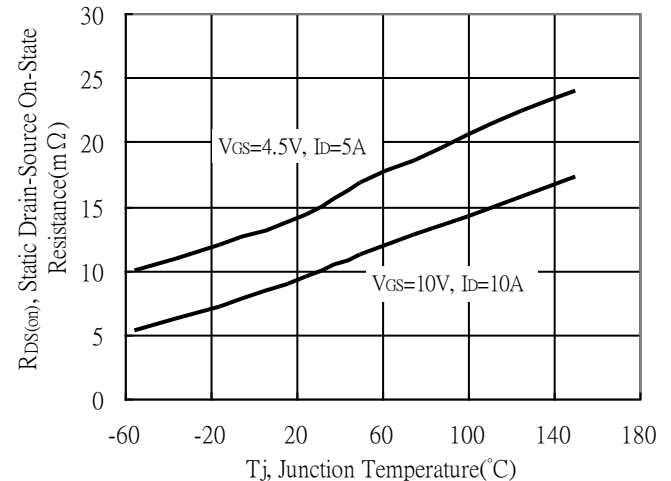
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

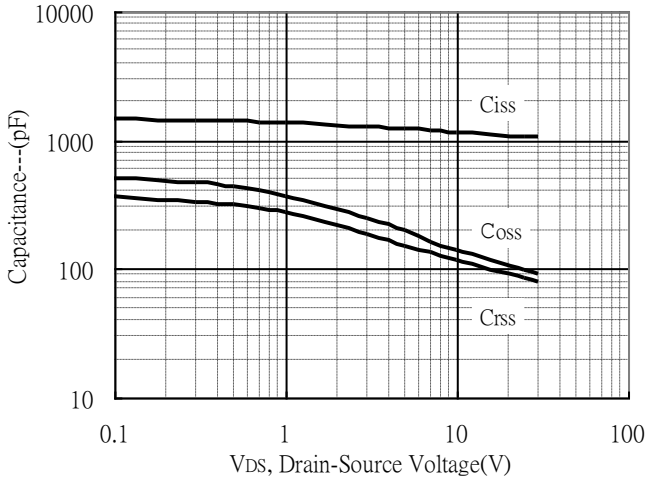


Drain-Source On-State Resistance vs Junction Temperature

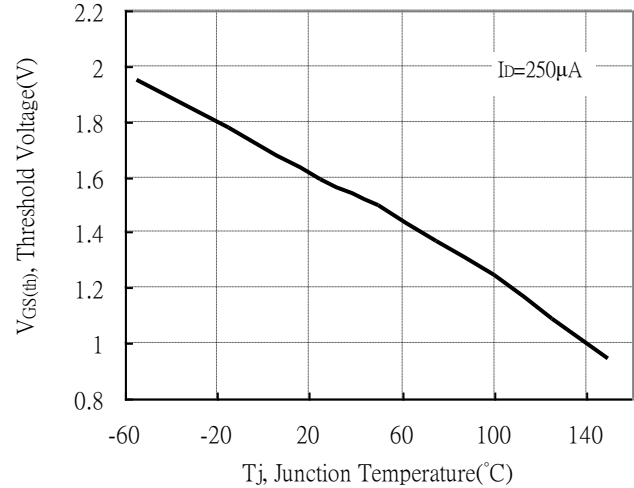


Typical Characteristics(Cont.)

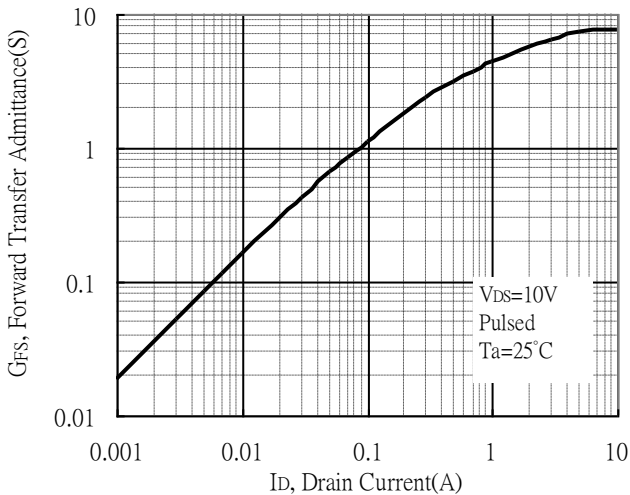
Capacitance vs Drain-to-Source Voltage



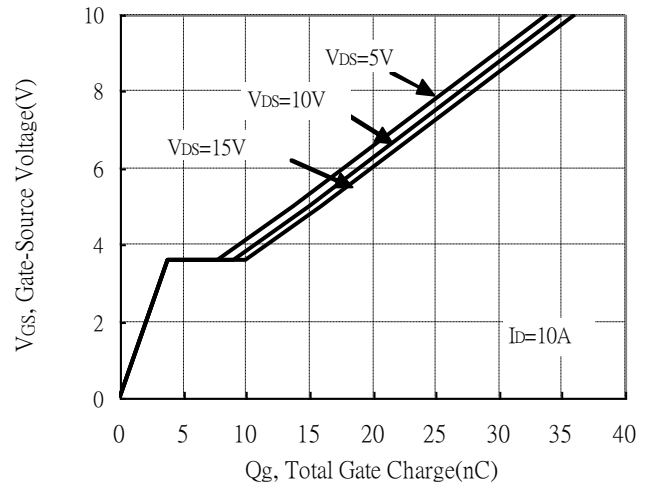
Threshold Voltage vs Junction Temperature



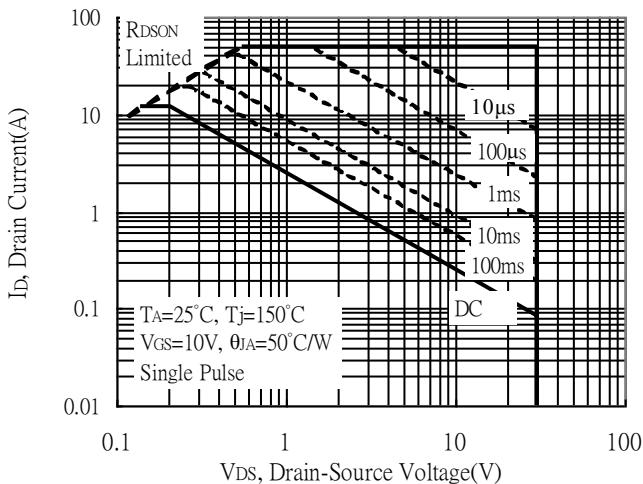
Forward Transfer Admittance vs Drain Current



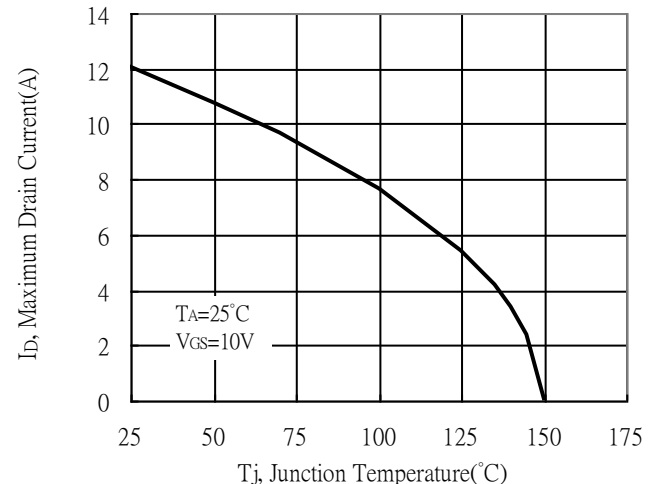
Gate Charge Characteristics



Maximum Safe Operating Area

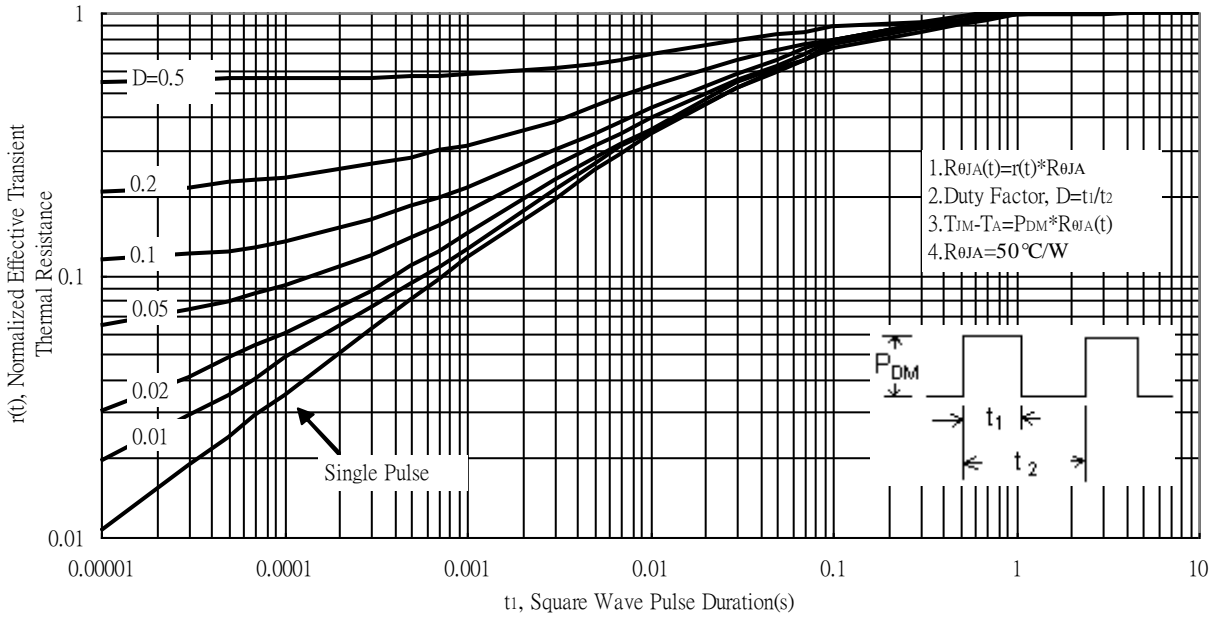


Maximum Drain Current vs Case Temperature

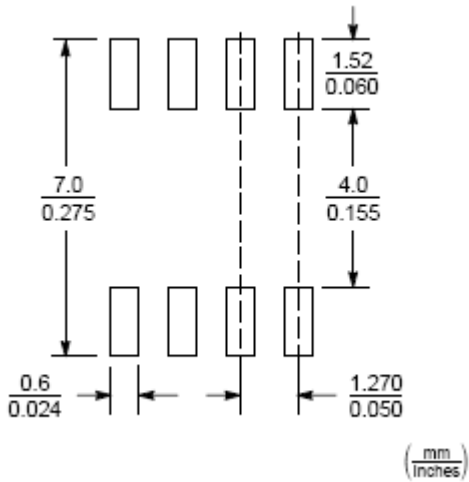


Typical Characteristics(Cont.)

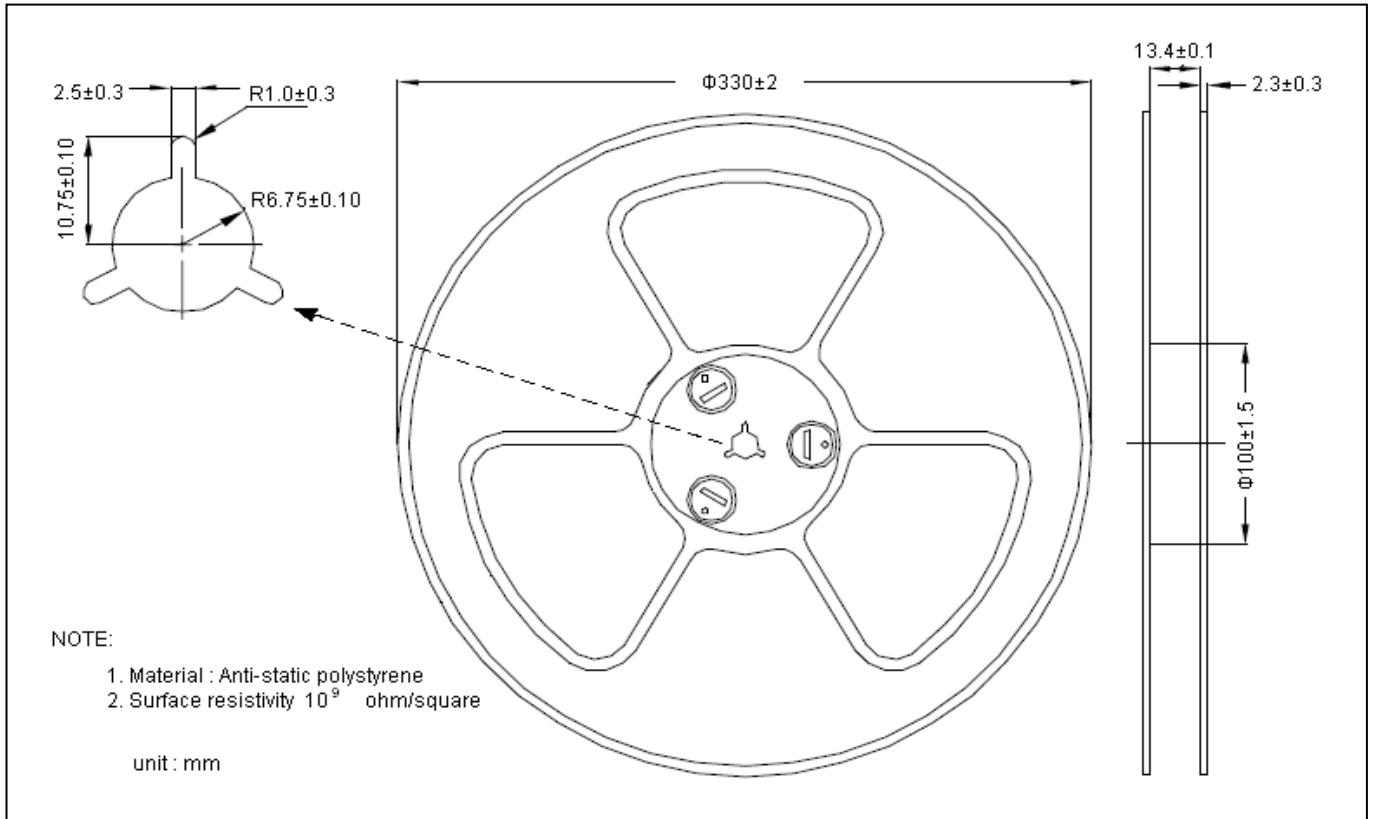
Transient Thermal Response Curves



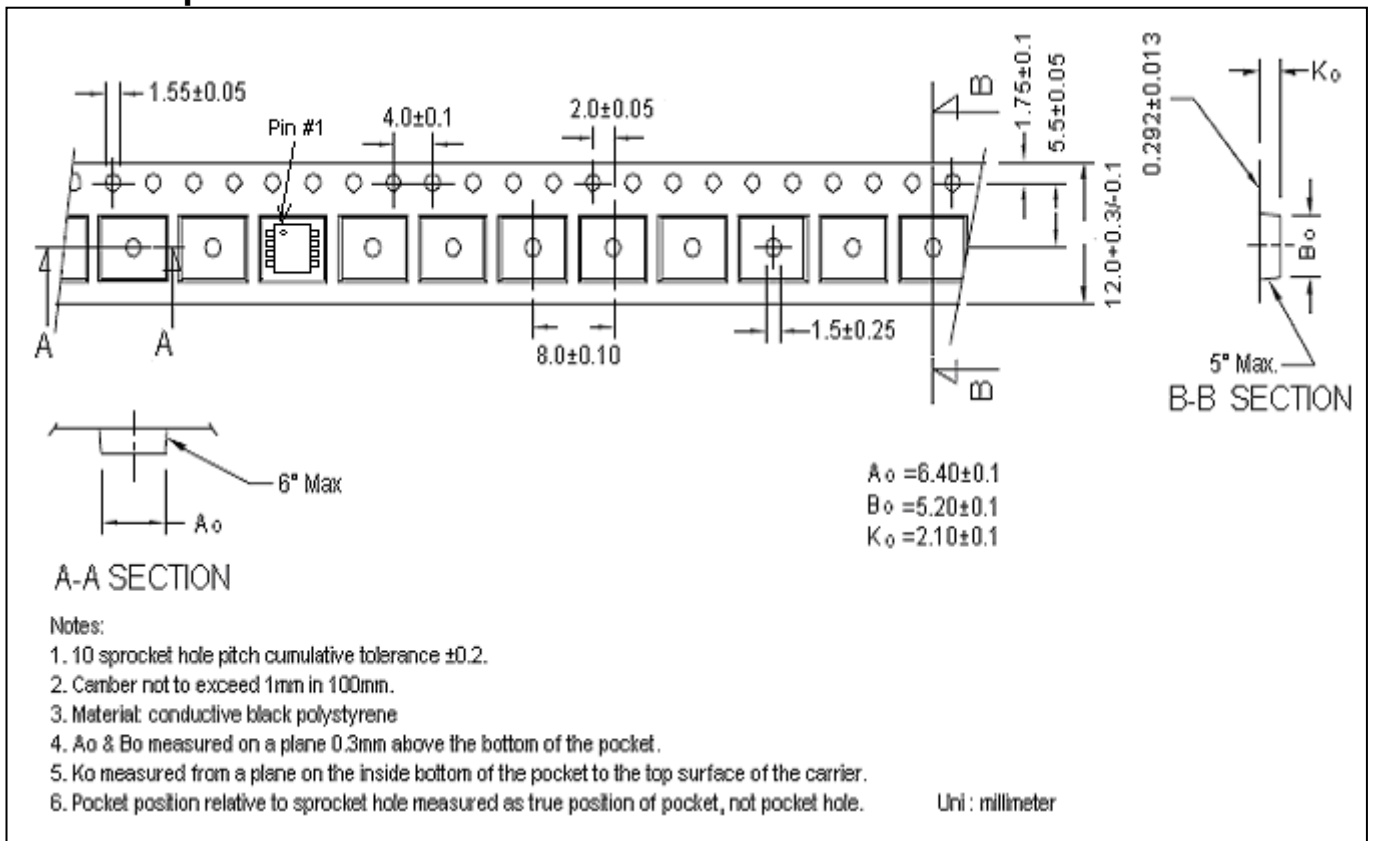
Recommended Soldering Footprint



Reel Dimension



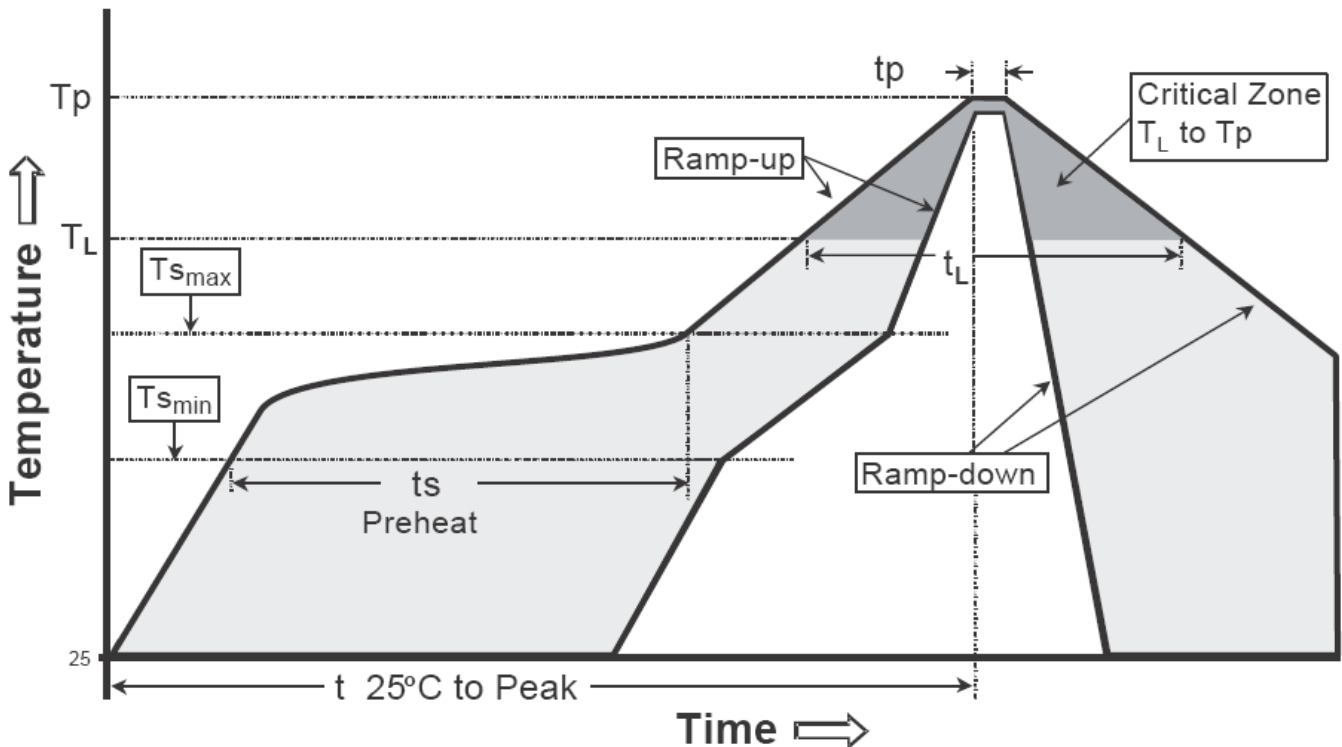
Carrier Tape Dimension



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

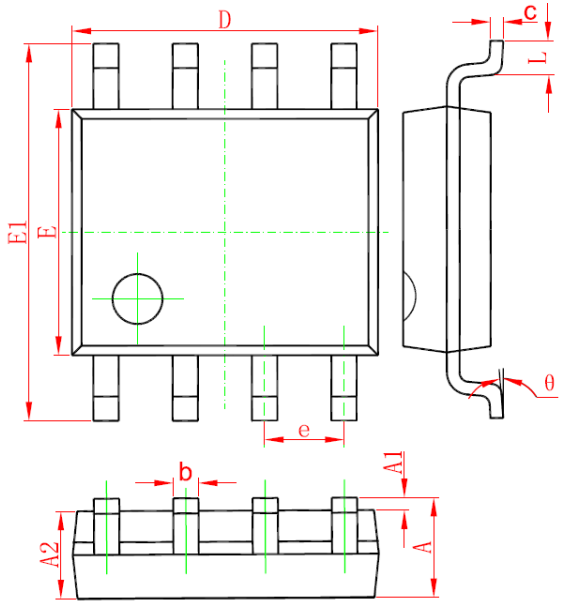
Recommended temperature profile for IR reflow



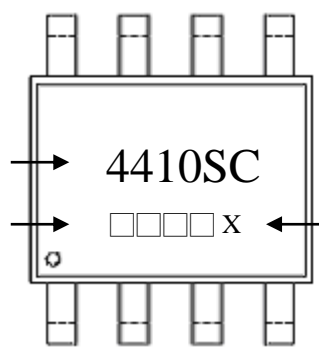
Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (Tsmax to Tp)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(Ts min)	100°C	150°C
-Temperature Max(Ts max)	150°C	200°C
-Time(ts min to ts max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (TL)	183°C	217°C
- Time (tL)	60-150 seconds	60-150 seconds
Peak Temperature(Tp)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

SOP-8 Dimension



Marking:



Device Code → 4410SC

Date Code → □□□□ X ← Assembly site code

Date Code(counting from left to right) :

1st code: year code, the last digit of Christian year

2nd code : month code, Jan→A, Feb→B, Mar→C, Apr→D
 May→E, Jun→F, Jul→G, Aug→H, Sep→J,
 Oct→K, Nov→L, Dec→M

3rd and 4th codes : production serial number, 01~99

Assembly site code : blank→ site 1, G →site 2

8-Lead SOP-8 Plastic Package
 CYStek Package Code: Q8

*: Typical

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069	E	3.800	4.000	0.150	0.157
A1	0.100	0.250	0.004	0.010	E1	5.800	6.200	0.228	0.244
A2	1.350	1.550	0.053	0.061	e	*1.270		*0.050	
b	0.330	0.510	0.013	0.020	L	0.400	1.270	0.016	0.050
c	0.170	0.250	0.006	0.010	θ	0°	8°	0°	8°
D	4.700	5.100	0.185	0.200					

- Notes:** 1.Controlling dimension: millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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